



ABSTRACT

SYSTEM AND METHOD FOR THE SORTING OF IC UNITS

- 5 A method for processing a plurality of IC units comprising the steps of: inspecting said units at a first inspection station; moving said IC units along a linearly defined path to a second inspection station; inspecting the units at said second inspection station; flipping said units; inspecting the units at said third inspection station, and; sorting said units into pre-defined categories.

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Fig 2